TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ($L^2-\pi$ -MOSVI)

TPC8301

Lithium Ion Battery Applications
Portable Equipment Applications
Notebook PCs

• Small footprint due to small and thin package

• Low drain-source ON resistance : $RDS(ON) = 95 \text{ m}\Omega \text{ (typ.)}$

• High forward transfer admittance : $|Y_{fs}| = 4 S \text{ (typ.)}$

• Low leakage current : $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -30 \text{ V)}$

• Enhancement-mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA)}$

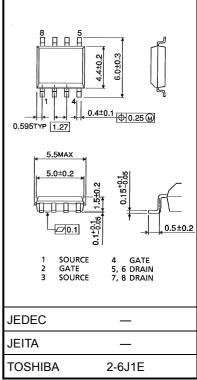
Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vo	ltage	V_{DSS}	-30	V	
Drain-gate volta	ge (R _{GS} = 20 kΩ)	V_{DGR}	-30	V	
Gate-source vol	tage	V _{GSS}	±20	V	
Drain current	D C (Note 1)	I _D	-3.5	Α	
Diain current	Pulse (Note 1)	I_{DP}	-30 -30 ±20	ζ.	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.5	W	
(t = 10 s) (Note 2a)	Single-devece value at dual operation (Note 3b)	P _{D (2)}	1.0		
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.75	W	
	Single-devece value at dual operation (Note 3b)	P _{D (2)}	0.45		
Single pulse ava	lanche energy (Note 4)	E _{AS}	16	mJ	
Avalanche curre	nt	I _{AR}	-3.5	Α	
Repetitive avalar (Note	nche energy e 2a, Note 3b, Note 5)	E _{AR}	0.10	mJ	
Channel tempera	ature	T _{ch}	150		
Storage tempera	ture range	T _{stg}	− 55 ~ 150		

Note: For (Note 1), (Note 2a), (Note 2b), (Note 3a), (Note 3b), (Note 4) and (Note 5), please refer to the next page.

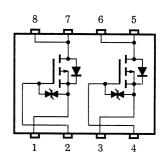
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm



Weight: 0.080 g (typ.)

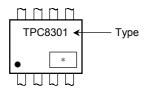
Circuit Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3		
	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	125 °C/W		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	167	C/VV	
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	278		

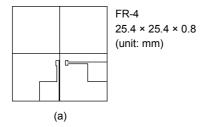
Marking

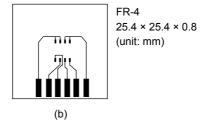


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a)
- b) Device mounted on a glass-epoxy board (b)





Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.)

Note 4:
$$V_{DD}$$
 = -24 V, T_{ch} = 25°C (Initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = -3.5 A

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

Note 6: • on lower left of the marking indicates Pin 1.

* shows lot number. (year of manufacture: last decimal digit of the year of manufacture, month of manufacture: January to December are denoted by letters A to L respectively.)

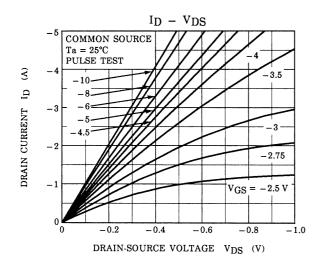
Electrical Characteristics (Ta = 25°C)

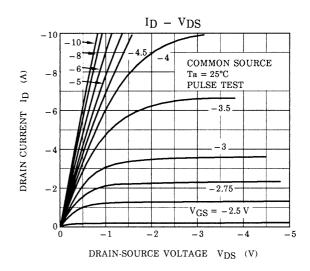
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA	
Drain cut-OFF	current	I _{DSS}	V _{DS} = -30 V, V _{GS} = 0 V	_	_	-10	μA	
Drain-source br	eakdown voltage	V _{(BR) DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30	_	_	٧	
Gate threshold v	voltage	V_{th}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-0.8	_	-2.0	٧	
Drain-source O	N recistance	R _{DS (ON)}	$V_{GS} = -4 \text{ V}, I_D = -1.8 \text{ A}$		155	190	mΩ	
Dialii-souice O	iv resistance	R _{DS (ON)}	V _{GS} = -10 V, I _D = -1.8 A	1 1 1		120	11152	
Forward transfer admittance		Y _{fs}	V _{DS} = -10 V, I _D = -1.8 A	2	4	_	S	
Input capacitano	e	C _{iss}		_	540	_		
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	80	_	pF	
Output capacita	nce	C _{oss}	1	_	290	_		
Switching time	Rise time	t _r	$V_{GS} \stackrel{0}{\circ} V \longrightarrow R_{L} = 8.3 \Omega$	_	11	_		
	Turn-ON time	t _{on}		_	17	_	- ns	
	Fall time	t _f		_	11	_		
	Turn-OFF time	t _{off}	$V_{ m DD} \ = \ -15 m V$ $ m Duty \ \le 1\%, \ t_{ m W} = 10 \mu m s$	_	70	_		
Total gate charge (Gate-source plus gate-drain)		Qg		_	18			
Gate-source charge		Q _{gs}	$V_{DD} \approx -24 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$		13	_	nC	
Gate-drain ("miller") charge		Q _{gd}			5	_		

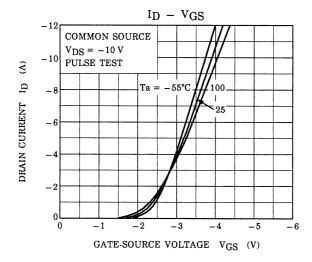
Source-Drain Ratings and Characteristics (Ta = 25°C)

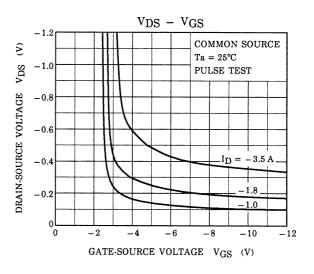
Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-14	Α
Forward voltage	(diode)	V _{DSF}	I _{DR} = -3.5 A, V _{GS} = 0 V	_	_	1.2	V

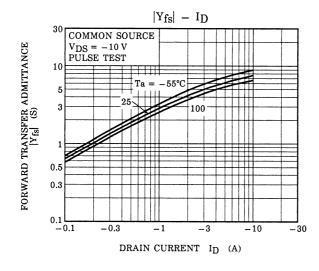
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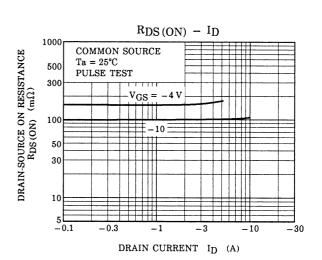


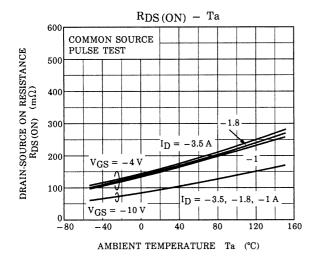


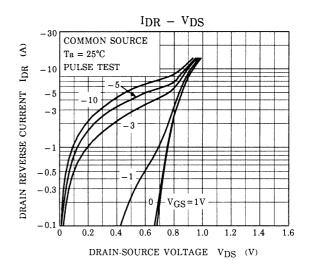


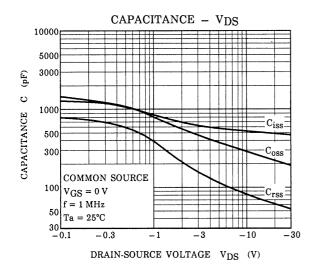


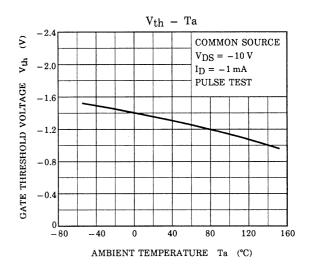


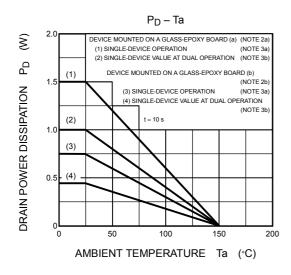


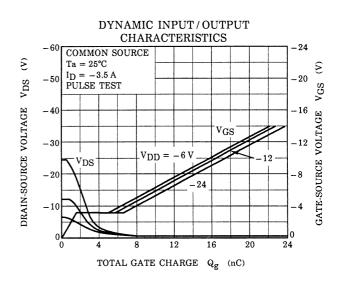




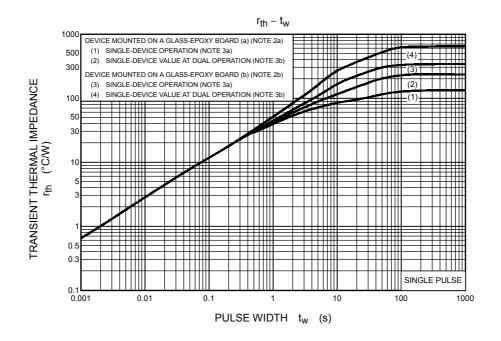


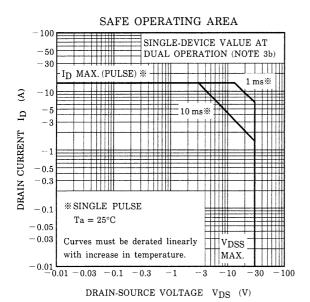


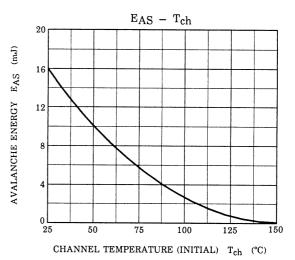


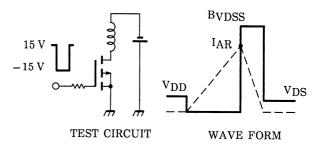


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$$\begin{array}{l} T_{ch} = 25^{\circ}C \ (Initial) \\ Peak \ I_{AR} = -3.5 \ A, \ R_G = 25 \ \Omega \\ V_{DD} = -24 \ V, \ L = 1.48 \ mH \end{array} \\ E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot (\ \frac{B_{VDSS}}{B_{VDSS} - V_{DD}}) \\ \end{array} \label{eq:continuous}$$

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